Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/039,827	CHOW ET AL.	
Examiner	Art Unit	
Zohreh A. Fay	1618	

	SEARCHED		
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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(INCLUDING SEA	NOTES	GY)
	DATE	EXMR
STIC Library search	2/15/20	06 Z.F
Inventorship search	2/15/20	06 Z.F